TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74VCXH16646FT

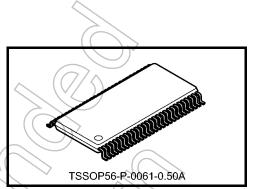
Low-Voltage 16-Bit Bus Transceiver/Register with Bushold

The TC74VCXH16646FT is a high-performance CMOS 16-bit bus transceiver/register. Designed for use in 1.8-V, 2.5-V or 3.3-V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

This device is bus transceiver with 3-state outputs, D-type flip-flops, and control circuitry arranged for multiplexed transmission of data directly from the internal registers.

The A, B data inputs include active bushold circuitry, eliminating the need for external pull-up resistors to hold unused or floating data inputs at a valid logic level.

All inputs are equipped with protection circuits against static discharge.



Weight: 0.25 g (typ.)

Features (Note)

- Low-voltage operation: V_{CC} = 1.8 to 3.6 V
- Bushold on data inputs eliminating the need for external pull-up/pull-down resistors
- High-speed operation : $t_{pd} = 2.9 \text{ ns (max)} (V_{CC} = 3.0 \text{ to } 3.6 \text{ V})$

: $t_{pd} = 3.5 \text{ ns (max) (V}_{CC} = 2.3 \text{ to } 2.7 \text{ V})$

 $: t_{pd} = 7.0 \text{ ns (max)} (V_{CC} = 1.8 \text{ V})$

- 3.6-V tolerant control inputs
- Output current: I_{OH}/I_{OL} = ±24 mA (min) (V_{CC} = 3.0 V)

 $: I_{OH}/I_{OL} = \pm 18 \text{ mA (min) (V}_{CC} = 2.3 \text{ V)}$

 $: I_{OH}/I_{OL} = \pm 6 \text{ mA (min) (V}_{CC} = 1.8 \text{ V)}$

- Latch-up performance: -300 mA
- ESD performance: Machine model $\geq \pm 200 \text{ V}$

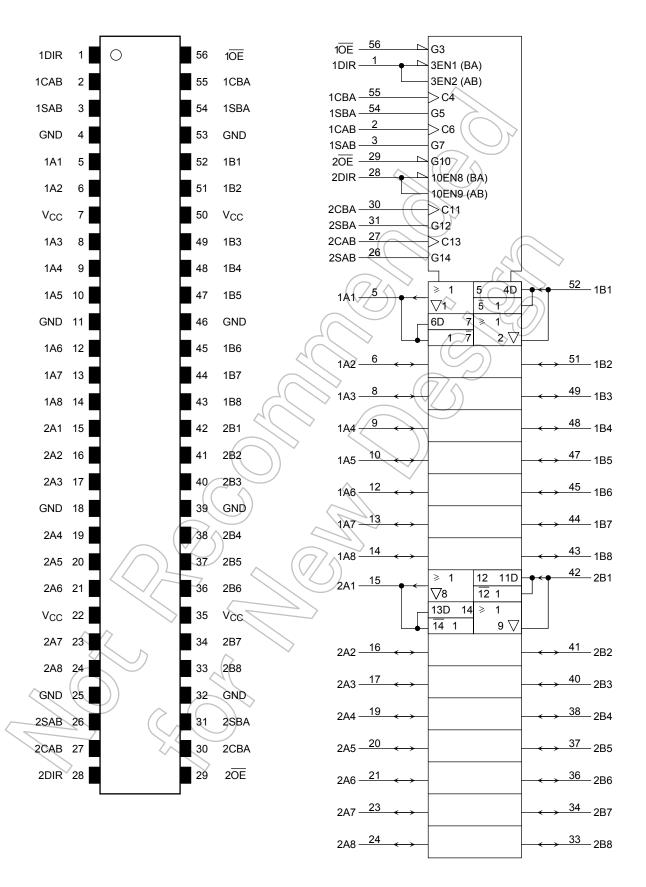
Human body model ≥ ±2000 V

Package: TSSOP

Note: Do not apply a signal to any bus pins when it is in the output mode. Damage may result.

Pin Assignment (top view)

IEC Logic Symbol



Truth Table

		Contro	I Inputs			Ві	ıs	Function
ŌĒ	DIR	CAB	СВА	SAB	SBA	Α	В	Function
		X*	X*	Х	x x		Input	The output functions of A and B Busses are
Н	Х	^*	^	^	^	Z	Z	disabled.
П	^			X	Х	Х	X	Both A and B Busses are used as inputs to the internal flip-flops. Data on the Bus will be stored on the rising edge of the Clock.
						Input	Output	
		X*	X*	L	Х	L	L <	The data on the A bus are displayed on the B bus.
						Н	Н	
		_	X*	L	X	L	L	The data on the A bus are displayed on the B Bus, and are stored into the A storage
L	Н		^	_	_ ^ [H	flip-flops on the rising edge of CAB.
		X*	X*	Н	х	х	Qn	The data in the A storage flop-flops are displayed on the B Bus.
			X*	Н	Х	L (The data on the A Bus are stored into the A storage flip-flops on the rising edge of CAB, and the stored data propagate directly onto the B Bus.
		X*	X*	х	L	Output L	Input L H	The data on the B Bus are displayed on the A bus.
L	L	X*		x		H (T	The data on the B Bus are displayed on the A Bus, and are stored into the B storage flip-flops on the rising edge of CBA.
		X*	X*	x	H	Qn	X	The data in the B storage flip-flops are displayed on the A Bus.
		X*		×) н	L	L	The data on the B Bus are stored into the B storage flip-flops on the rising edge of CBA, and the stored data propagate directly onto the A Bus.

X: Don't care

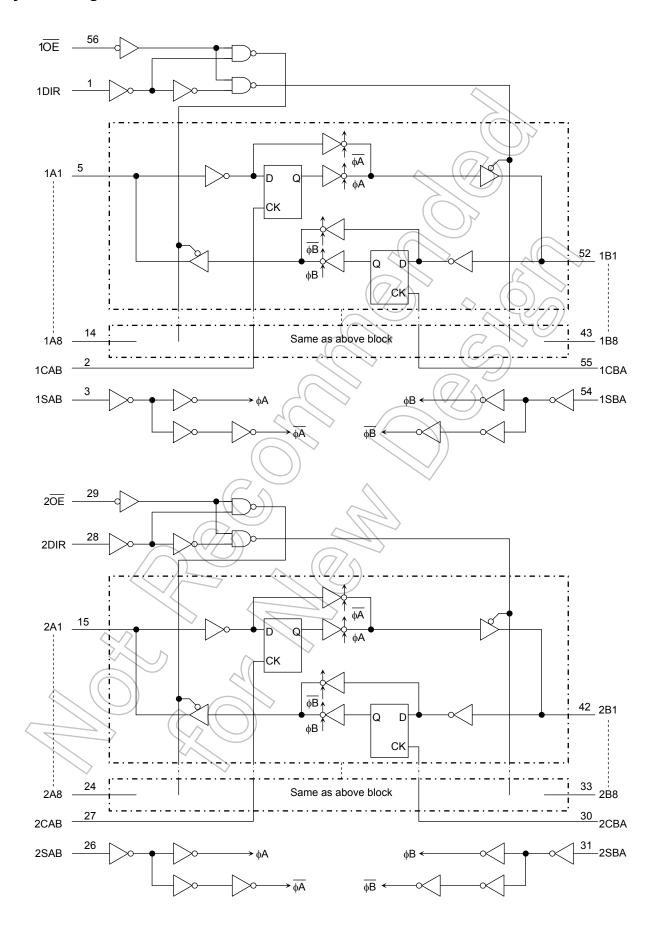
Z: High impedance

Qn: The data stored into the internal flip-flops by most recent low to high transition of the clock inputs.

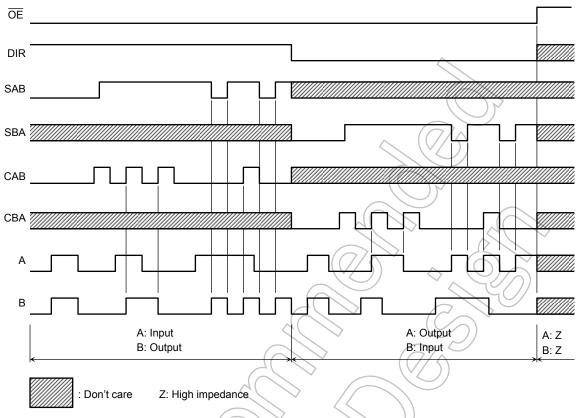
*: The clocks are not internally with either OE or DIR.

Therefore, data on the A and/or B busses may be clocked into the storage flip-flops at any time.

System Diagram



Timing Chart



Absolute Maximum Ratings (Note 1)

	Characteristics	Symbol Rating		Unit
Power supp	ly voltage	(V _{CC}))	-0.5 to 4.6	V
DC input	(DIR, \overline{OE} , CAB, CBA, SAB, SBA)	77	-0.5 to 4.6	V
voltage	(An, Bn)	VIN	-0.5 to V _{CC} + 0.5 (Note 2)	V
DC output voltage	(An, Bn)	V _{OUT}	-0.5 to V _{CC} + 0.5 (Note 3)	V
Input diode	current	lık	-50	mA
Output diode	e current	lok	±50 (Note 4)	mA
Output current		IQÛ T	±50	mA
Power dissipation		(PD	400	mW
DC V _{CC} /ground current per supply pin		Icc/IGND	±100	mA
Storage tem	pperature	T _{stg}	-65 to 150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

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Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2: OFF state

Note 3: High or low state. IOUT absolute maximum rating must be observed.

Note 4: $V_{OUT} < GND, V_{OUT} > V_{CC}$



Operating Ranges (Note 1) (Note 2)

Characteristics		Symbol	Rating	Unit
Power sur	oply voltage	V _{CC}	1.8 to 3.6	V
rower sup	opiy voltage	v CC	1.2 to 3.6 (Note 3)	V
Input	(DIR, $\overline{\text{OE}}$, CAB, CBA, SAB, SBA)	V _{IN}	-0.3 to 3.6	V
voltage	(An, Bn)		0 to V _{CC} (Note 4)	
Output voltage	(An, Bn)	V _{OUT}	0 to V _{CC} (Note 5)	V
			±24 (Note 6)	
Output cu	Output current		±18 (Note 7)	mA
			±6 (Note 8)	(())
Operating temperature		T _{opr}	-40 to 85	\°C
Input rise	and fall time	dt/dv	0 to 10 (Note 9)	ns/V

- Note 1: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either V_{CC} or GND.
- Note 2: Floating or unused control inputs must be held high or low.
- Note 3: Data retention only
- Note 4: OFF state
- Note 5: High or low state
- Note 6: $V_{CC} = 3.0 \text{ to } 3.6 \text{ V}$
- Note 7: $V_{CC} = 2.3 \text{ to } 2.7 \text{ V}$
- Note 8: $V_{CC} = 1.8 \text{ V}$
- Note 9: $V_{IN} = 0.8$ to 2.0 V, $V_{CC} = 3.0$ V



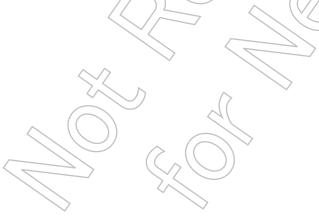
Electrical Characteristics

DC Characteristics (Ta = -40 to 85° C, 2.7 V < $V_{CC} \le 3.6$ V)

Characteristics		Symbol	Test Condition		V _{CC} (V)	Min	Max	Unit	
H-level		V _{IH}	_		2.7 to 3.6	2.0	_		
Input voltage	L-level	V _{IL}	_	_	2.7 to 3.6	_	0.8	V	
				I _{OH} = -100 μA	2.7 to 3.6	V _{CC} - 0.2	_		
	H-level	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -12 mA	//2.7	2.2	_		
				$I_{OH} = -18 \text{ mA}$	3.0	2.4			
Output voltage				I _{OH} = -24 mA	3.0	2.2	_	V	
	L-level			$I_{OL} = 100 \mu\text{A}$	2.7 to 3.6		0.2		
		V _{OL}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OL} = 12 \text{ mA}$	2.7	#	0.4		
				$I_{OL} = 18 \text{ mA}$	3.0		0.4		
				I _{OL} ≠ 24 mA	3.0		0.55		
Input leakage current (DIR, OE, CAB, CBA, SAB, SBA)		I _{IN}	V _{IN} = 0 to 3.6 V		2.7 to 3.6	\(\lambda\)	±5.0	μА	
Bushold input minimum	n drive hold		V _{IN} = 0.8 V		3.0)	75	_	^	
current		lı (HOLD)	V _{IN} = 2.0 V	\ \(\begin{align*} \text{O} align*	3.0	-75	_	μА	
Bushold input over-drive current to		li va av		(Note 1)	3.6	_	450	μА	
change state		I _I (OD)		(Note 2)	3.6		-450	μΑ	
3-state output OFF state current		loz	$V_{IN} = V_{IH}$ or V_{IL} $V_{OUT} = V_{CC}$ or GND		2.7 to 3.6		±10.0	μА	
Quiescent supply current		Icc	V _{IN} = V _{CC} or GND	_	2.7 to 3.6		20.0	μΑ	
Increase in I _{CC} per inp	ut	Δlcc	$V_{IH} = V_{CC} - 0.6 V$		2.7 to 3.6		750	μΑ	

Note 1: An external driver must source at least the specified current to switch from LOW-to-HIGH.

Note 2: An external driver must sink at least the specified current to switch from HIGH-to-LOW.



DC Characteristics (Ta = -40 to 85°C, 2.3 V \leq V_{CC} \leq 2.7 V)

Characteristics		Symbol	Test Condition			Min	Max	Unit	
		Cymbol	rest donation		V _{CC} (V)	141111	IVIAX	Offic	
Input voltage	H-level	V _{IH}	_	_		1.6	_	V	
input voltage	L-level	V _{IL}	_		2.3 to 2.7	_	0.7	\ \ \	
				I _{OH} = -100 μA	2.3 to 2.7	V _{CC} - 0.2	_		
	H-level	V _{OH}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OH} = -6 \text{ mA}$	2.3	2.0			
				I _{OH} = -12 mA	2.3	1.8	_	V	
Output voltage				I _{OH} = -18 mA	2.3	1.7	_		
	L-level	V _{OL}	$V_{IN} = V_{IH}$ or V_{IL}	I _{OL} = 100 μA	2.3 to 2.7	_	0.2		
				I _{OL} = 12 mA	2.3	_	0.4		
				I _{OL} = 18 mA	2.3		0.6		
Input leakage current (DIR, $\overline{\text{OE}}$, CAB, CBA,	SAB, SBA)	I _{IN}	V _{IN} = 0 to 3.6 V		2.3 to 2.7		±5.0	μА	
Bushold input minimun	n drive hold	1	V _{IN} = 0.7 V		2.3	45) —		
current		I _I (HOLD)	V _{IN} = 1.6 V		2.3	45/	_	μА	
Bushold input over-drive current to change state		li (ann)		(Note 1)	2.7	~ —	300		
		I _I (OD)		(Note 2) 2.7		_	-300	μА	
3-state output OFF state current		I _{OZ}	V _{IN} = V _{IH} or V _{IL} V _{OUT} = V _{CC} or GND		2.3 to 2.7	_	±10.0	μА	
Quiescent supply curre	ent	Icc	$V_{IN} = V_{CC}$ or GND		2.3 to 2.7	_	20.0	μА	

Note 1: An external driver must source at least the specified current to switch from LOW-to-HIGH.

Note 2: An external driver must sink at least the specified current to switch from HIGH-to-LOW.

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DC Characteristics (Ta = -40 to 85° C, $1.8 \text{ V} \le \text{V}_{\text{CC}} < 2.3 \text{ V})$

Characteristics		Symbol	Test Condition		V _{CC} (V)	Min	Max	Unit	
Input voltage	H-level		_		1.8 to 2.3	0.7 × V _{CC}	_	V	
input voltage	L-level	V _{IL}	_		1.8 to 2.3		0.2 × V _{CC}	V	
	H-level	Voh	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -100 μA	1.8	VCC - 0.2	١		
Output voltage		011		$I_{OH} = -6 \text{ mA}$	71.8	1.4		V	
	L-level	V _{OL}	V _{IN} = V _{IH} or V _{IL}	I _{OL} = 100 μA	1.8	_	0.2		
				I _{OL} = 6 mA	1.8	_	0.3		
Input leakage current (DIR, $\overline{\text{OE}}$, CAB, CBA,	SAB, SBA)	I _{IN}	V _{IN} = 0 to 3.6 V		1.8		±5.0	μА	
Bushold input minimum	n drive hold	I _{I (HOLD)}	V _{IN} = 0.36 V		1.8	25 —			
current			V _{IN} = 1.26 V	(7/6)	1.8	-25	> _	μΑ	
Bushold input over-drive current to change state				(Note 1)	1.8	1240	200	Δ.	
		I _{I (OD)}		(Note 2)	1.8		-200	μΑ	
3-state output OFF state current		l _{OZ}	V _{IN} = V _{IH} or V _{IL} V _{OUT} = V _{CC} or GND		1.8		±10.0	μА	
Quiescent supply curre	nt	Icc	$V_{IN} = V_{CC}$ or GND	· (7/	1.8		20.0	μΑ	

Note 1: An external driver must source at least the specified current to switch from LOW-to-HIGH.

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Note 2: An external driver must sink at least the specified current to switch from HIGH-to-LOW.





AC Characteristics (Ta = –40 to 85°C, input: $t_r = t_f$ = 2.0 ns, C_L = 30 pF, R_L = 500 Ω) (Note 1)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Min	Max	Unit
			1.8	100	_	
Maximum clock frequency	f _{max}	Figure 1, Figure 3	2.5 ± 0.2	200	_	MHz
			3.3 ± 0.3	250	_	
Dranagation delay time	4		1.8	1.5	7.0	
Propagation delay time (An, Bn-Bn, An)	t _{pLH}	Figure 1, Figure 2	2.5 ± 0.2	0.8	3.5	ns
(All, Bir-Bil, All)	tpHL		3.3 ± 0.3	0.6	2.9	
Propagation delay time	+		1.8	1.5	8.8	
(CAB, CBA-Bn, An)	t _{pLH} t _{pHL}	Figure 1, Figure 3	2.5 ± 0.2	0.8	4.4	ns
(0/15, 05/15/1, 7/11)	чрпс		3.3 ± 0.3	0.6	3.2	
Propagation delay time	t	4(>>	1.8	1.5	8.8	
(SAB, SBA-Bn, An)	t _{pLH} t _{pHL}	Figure 1, Figure 2	2.5 ± 0.2	0.8	4.4	ns
(O/LB, OB/CBII, /III)	чрпс		3.3 ± 0.3	0.6	3.5	
Output enable time	t.=0		1.8	4.5	9.8	
($\overline{\sf OE}$, DIR-An, Bn)	t _{pZL}	Figure 1, Figure 4, Figure 5	2.5 ± 0.2	0.8	4.9	ns
(OE, BIRTHI, BII)		4(>)	3.3 ± 0.3	0.6	3.8	
Output disable time	t_1 =		1.8	1.5	7.6	
($\overline{\sf OE}$, DIR-An, Bn)	t _{pLZ}	Figure 1, Figure 4, Figure 5	2.5 ± 0.2	0.8	4.2	ns
(OE, BIR-AII, BII)	t _{pHZ}		3.3 ± 0.3	0.6	3.7	
			1.8	4.0	_	
Minimum pulse width	t _{w (H)}	Figure 1, Figure 3	2.5 ± 0.2	1.5	_	ns
	t _{w (L)}		3.3 ± 0.3	1.5	_	
			1.8	2.5	_	
Minimum setup time	(t _s)	Figure 1, Figure 3	2.5 ± 0.2	1.5	_	ns
			3.3 ± 0.3	1.5	_	
//) [)	$\langle \langle \langle // \rangle \rangle$	1.8	1.0	_	
Minimum hold time	th	Figure 1, Figure 3	2.5 ± 0.2	1.0		ns
	>		3.3 ± 0.3	1.0		
$\wedge \wedge$	t		1.8	_	0.5	
Output to output skew	t _{osLH}	(Note 2)	2.5 ± 0.2	_	0.5	ns
	VOSHL	4 (3.3 ± 0.3	_	0.5	

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Note 1: For C_L = 50 pF, add approximately 300 ps to the AC maximum specification.

Note 2: Parameter guaranteed by design.

 $(t_{OSLH} = |t_{PLHm} - t_{PLHn}|, t_{OSHL} = |t_{PHLm} - t_{PHLn}|)$

Dynamic Switching Characteristics

(Ta = 25°C, input: $t_r = t_f = 2.0 \text{ ns}, C_L = 30 \text{ pF}, R_L = 500 \Omega$)

Characteristics	Symbol	Tost Co		Тур.	Unit		
Characteristics	Syllibol	Test Of	Test Condition			Offic	
		V _{IH} = 1.8 V, V _{IL} = 0 V	(Note)	1.8	0.25		
Quiet output maximum dynamic V _{OL}	V _{OLP}	V _{IH} = 2.5 V, V _{IL} = 0 V	(Note)	2.5	0.6	V	
, , , , , OL		$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$	(Note)	3.3	0.8		
	V _{OLV}	V _{IH} = 1.8 V, V _{IL} = 0 V	(Note)	1.8	-0.25		
Quiet output minimum dynamic V _{OI}		$V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$	(Note)	2.5	-0.6	V	
, 01		$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$	(Note)	3.3	-0.8		
	Voнv	V _{IH} = 1.8 V, V _{IL} = 0 V	(Note)	1.8	1.5		
Quiet output minimum dynamic V _{OH}		V _{IH} = 2.5 V, V _{IL} = 0 V	(Note)	2.5	1.9	V	
		V _{IH} = 3.3 V, V _{IL} = 0 V	(Note)	3.3	2.2		

Note: Parameter guaranteed by design.

Capacitive Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition		V _{CC} (V)	Тур.	Unit
Input capacitance	C _{IN}	(DIR, OE, CAB, CBA, SAB, SBA)	(7/1)	1.8, 2.5, 3.3	6	pF
Bus I/O capacitance	C _{I/O}	- C		1.8, 2.5, 3.3	7	pF
Power dissipation capacitance	C _{PD}	f _{IN} = 10 MHz	(Note)	1.8, 2.5, 3.3	20	pF

Note: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/16 (per bit)$



AC Test Circuit

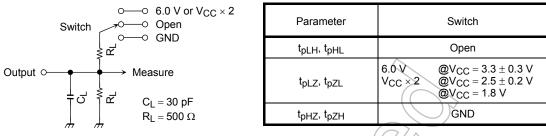


Figure 1 **AC Waveform** t_r 2.0 ns t_f 2.0 ns Input (An, Bn, SAB, SBA) GND Voh Output V_{M} (Bn, An) V_{OL} t_{pLH} tpHL Figure 2 tpLH, tpHL $t_r = 2.0 \, \text{ns} / t_f = 2.0 \, \text{ns}$ V_{IH} 90% Input (CAB, CBA) 10% GND $t_{W}\left(H\right)$ $t_{W}\left(L\right)$ - V_{IH} Input V_{M} (An, Bn) GND t_h (H) t_s (H) t_s (L) t_h (L) V_{OH} Output (Bn, An) - V_{OL}

Figure 3 $t_{pLH}, t_{pHL}, t_w, t_s, t_h$

tpLH

TPHL

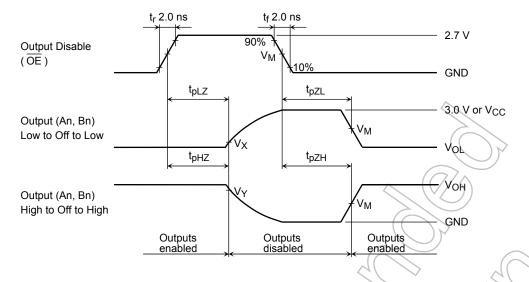


Figure 4 t_{pLZ}, t_{pH}, t_{pZ}, t_{pZH}

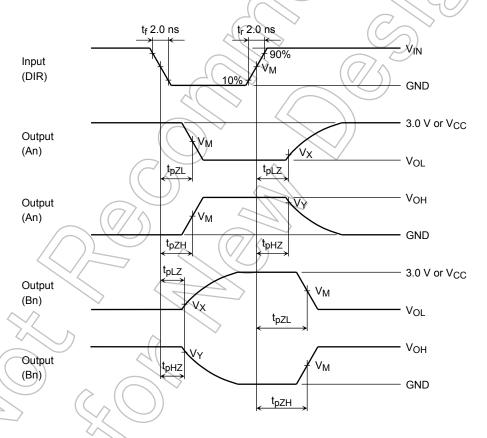


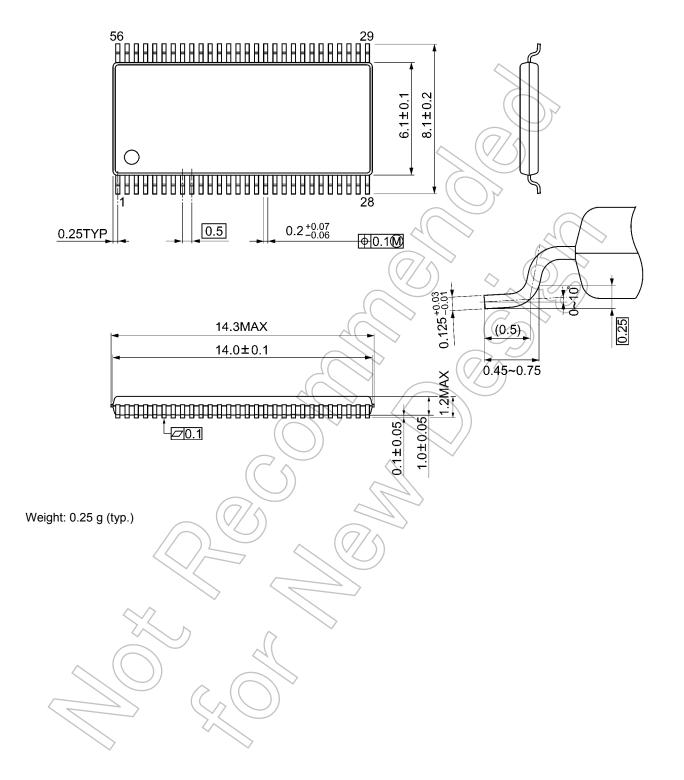
Figure 5 t_{pLZ}, t_{pH}, t_{pZ}, t_{pZH}

Symbol	Vcc							
Cymbol	$3.3\pm0.3~\textrm{V}$	$2.5\pm0.2\textrm{V}$	1.8 V					
V _{IH}	2.7 V	V _{CC}	V _{CC}					
V_{M}	1.5 V	V _{CC} /2	V _{CC} /2					
VX	V _{OL} + 0.3 V	V _{OL} + 0.15 V	V _{OL} + 0.15 V					
VY	V _{OH} – 0.3 V	V _{OH} – 0.15 V	V _{OH} – 0.15 V					

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Package Dimensions

TSSOP56-P-0061-0.50A Unit: mm



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